

Notice of References Cited	Application/Control No. 10/632,865		Applicant(s)/Patent Under Reexamination KIM, EUNG-SUN	
	Examiner DANIEL TEKLE		Art Unit 2621	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0118321	06-2003	Sparrell et al.	386/68
	B	US-			
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FOREIGN PATENT DOCUMENTS

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